

TRANSISTOR IGBT DIODE

$\Delta V_{CE}/\Delta V_F$ TEST SYSTEM 大電力熱抵抗テストシステム

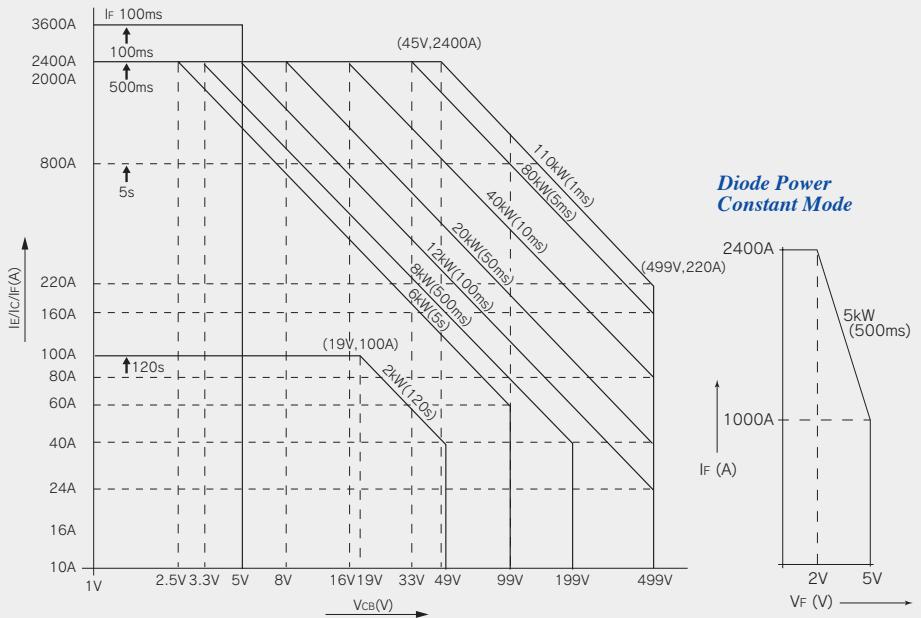
DVF540ZZGC 500V 3600A

●DVF540ZZGC is high power thermal resistance test system that maximum forcing current is 3600A. This overwhelming power area is appropriate for thermal judgement of power semiconductor such as power modules.

●DVF540ZZGC は最大印加電流 3600Aを持つ、大電力熱抵抗テスターです。この圧倒的なパワーエリアはパワーモジュールなどの電力用半導体の熱評価に最適です。



Forcing Power Range Diagram



MODEL	DVF540ZZGC	
MEASUREMENT RANGE		
$V_{BE1}/V_{CE1}/V_F$	0000mV~9999mV	
$\Delta V_{BE}/\Delta V_{CE}/\Delta V_F$	0000mV~1999mV	
SETTING RANGE		
MEASURABLE DEVICES	NPN, N-IGBT, N-DIODE	
V_{CB}/V_{CE}	1V~499V	$\pm(0.2\%+0.1V)$
I_E/I_F	00.1A~3600A	0.01A~0.99A 1.00A~99.9A 100A~999A 1000A~3600A
DIODE POWER CONSTANT	0000W~5000W	
I_M	001mA~1999mA	001mA~999mA 1000mA~1999mA
GATE LIMIT VOLTAGE	01.0V~19.9V	
POWER FORCING TIME(PT)	100μs~120s	
DELAY TIME(DT)	10μs~9.99ms	
LOWER GATE(LG)/UPPER GATE(UG)	0000mV~1999mV	
BINNING AND INTERFACE		
OPEN/SHORT CHECK	$V_F > 4V \cdots OPEN$ $V_F < 0.1V \cdots SHORT$	
BIN INDICATION	PASS, LOW, HIGH, AVAL, REJECT	
EXTERNAL I/F	Handler-I/F STANDARD	
EXT CONTROL I/F	IEEE-488 I/F STANDARD(GP-IB)	
DIMENSIONS & WEIGHT	550(W)×1060(D)×1700(H) (×7sets)~3,500kg	